

# INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(PTO-1449)

 ATTY. DOCKET NO.  
**070456-0016**

 SERIAL NO.  
**10/787,221**

 APPLICANT  
**Kouichi OKUGAMI, et al.**

 FILING DATE  
**February 27, 2004**

 GROUP  
**3682**

## U.S. PATENT DOCUMENTS

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/JK/		WO 91/00929	01-24-1991			English Abstract Only
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/JK/		JP 2002-031212	01-31-2002	Koyo Seiko Co., Ltd.		JAPAN (w/English Abstract)

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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						Yes	No
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## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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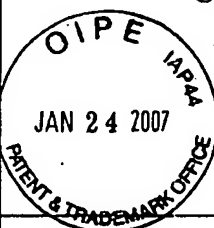
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/JK/		Japanese Office Action Issued in Japanese Patent Application No. JP 2002-194921, dated November 28, 2006.						
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